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AND TRADEMARK OFFICE**

Date of Deposit: February 6, 2004

Applicant(s): T. YONEYAMA et al


Serial No. : Not yet assigned

Filed : Herewith

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APPARATUS AND DEFECT  
INSPECTION METHOD

Art Unit :  
Examiner :

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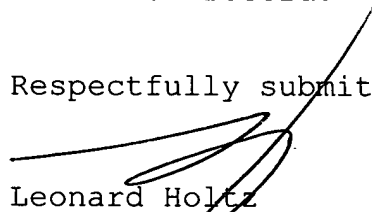
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Submitted herewith are copies of the publications identified on the attached Patent Office form PTO/SB/08A.

It is respectfully requested that the publications submitted herewith be considered and made of record.

Respectfully submitted,

  
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Substitute for Form 1449A/PTO  <b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b>				Application Number		
				Filing Date		Herewith
				First Named Inventor		YONEYAMA
				Group Art Unit		
				Examiner Name		
Sheet	1	of	1	Attorney Docket Number		04083/LH

### U.S. PATENT DOCUMENTS

Exam. Inits*	Cite No <sup>1</sup>	Document Number	Kind Code <sup>2</sup>	Name of Patentee or Applicant	Publication Date MM-DD-YYYY	Relevant Portion

### FOREIGN PATENT DOCUMENTS

Exam Inits*	Cite No <sup>1</sup>	offc <sup>3</sup>	Document Number <sup>4</sup>	Kind Code <sup>5</sup>	Name of Patentee or Applicant	Publication Date MM-DD-YYYY	Relevant Portion	T <sup>6</sup>
		JP	6-165019	A	YOSHIDA et al	06-10-1994		X*
		JP	11-84228	A	HASHIMOTO	03-26-1999		X*
		JP	2001-189358	A	SHISHIDO et al	07-10-2001		X*
			*English abstract attached.					

Examiner Signature		Date Considered	
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\* EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

<sup>1</sup> Unique citation designation number. <sup>2</sup> See kinds of U.S. Patent Documents. <sup>3</sup> Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). <sup>4</sup> For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. <sup>5</sup> Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. <sup>6</sup> Place a check here if English translation is attached.

DATE MAILED: **February 6, 2004**